## Notice of References Cited

Application/Control No. 09/768,281	Applicant(s)/Pater Reexamination LEE, CHEN-HO	nt Under	
Examiner	Art Unit	•	
Chriss S. Yoder, III	2612	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,538,695 B1	03-2003	Xiao et al.	348/245
	В	US-5,500,522 A	03-1996	Eshraghian et al.	250/208.1
	ပ	US-2002/0118289 A1	08-2002	Choi, Soo-Chang	348/308
	D	US-6,449,014 B1	09-2002	Throngnumchai, Kraisorn	348/308
	E	US-6,538,693 B1	03-2003	Kozuka, Hiraku	348/241
	F	US-6,542,194 B1	04-2003	Juen, Masahiro	348/367
	G	US-6,760,070	07-2004	Merrill et al.	348/294
	Н	US-			
	_	US-			
	٦	US-			·
	K	US-			
	L	US-			
	Μ	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					÷.
	ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*	*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	·		
	٧			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.